

Notice of References CitedApplication/Control No.
09/591,437Applicant(s)/Patent Under
Reexamination
XUE ET AL.Examiner
Thoi V DuongArt Unit
2871

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6141076	10-2000	Liu et al.	349/134
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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FOREIGN PATENT DOCUMENTS

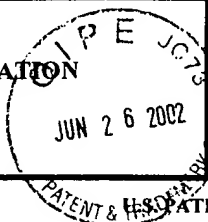
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Applicant(s) XUE et al	
Filing Date 06/09/00	Group Art Unit 2871

U.S. PATENT DOCUMENTS

*EXAMINER INITIAL	REF	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
<i>YMS</i>		4,778,259	10/18/88	KITAYAMA ET AL	350		
<i>YMS</i>		5,172,257	12/15/92	PATEL	359		

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